Conductivity Calibration Report

Date of Report: Serial Number: 'as received', without cleaning or adjustments, allow oblem or indicates cell cleaning is necessary, then a received' calibration is not performed if the sensor is as received' calibration or the previous calibration of the previous calibration of the previous calibration as received' calibration or the previous calibration. SOFT enter the chosen coefficients. The coefficients at the SEASOFT manual). Calibration coefficients.	second calibration is damaged or non- requency to better represents the tt'slope' allows small
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✓ Performed	☐ Not Performed
Drift since last cal: -0.000	PSU/month*
REPLATINIZING' Performed	✓ Not Performed
Drift since Last cal:	PSU/month*
	Drift since last cal: -0.000

*Measured at 3.0 S/m

Cell cleaning and electrode replatinizing tend to 'reset' the conductivity sensor to its original condition. Lack of drift in post-cleaning-calibration indicates geometric stability of the cell and electrical stability of the sensor circuit.